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N-channel 100 V 4.8 mΩ standard level MOSFET in D2PAK 12 April 2013 Product data sheet

1. **General description**

Standard level N-channel MOSFET in a D2PAK package qualified to 175 °C. Part of NXP's "NextPower Live" portfolio, the PSMN4R8-100BSE complements the latest "hotswap" controllers - robust enough to withstand substantial inrush currents during turn on, whilst offering a low R_{DS(on)} characteristic to keep temperatures down and efficiency up in continued use. Ideal for telecommunication systems based on a 48 V backplane / supply rail.

2. **Features and benefits**

- Enhanced forward biased safe operating area for superior linear mode operation
- Very low R_{DS(on)} for low conduction losses

Applications 3.

- Electronic fuse
- Hot swap
- Load switch
- Soft start

. . .

4. Quick reference data

1.1.1

Table 1. Qu	ick reference data						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	100	V
I _{DM}	peak drain current	pulsed; T_{mb} = 25 °C; $t_p \le 10 \ \mu$ s; Fig. 4		-	-	707	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 2</u>		-	-	405	W
Static charact	teristics						
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; Fig. 12		-	4.1	4.8	mΩ
Dynamic chai	racteristics	·					
Q _{GD}	gate-drain charge	V_{GS} = 10 V; I _D = 25 A; V _{DS} = 50 V;		-	59	83	nC
Q _{G(tot)}	total gate charge	<u>Fig. 14;</u> <u>Fig. 15</u>		-	196	278	nC





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Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Avalanche Ruggedness							
E _{DS(AL)S}	non-repetitive drain- source avalanche energy	$V_{GS} = 10 \text{ V}; \text{T}_{j(init)} = 25 ^{\circ}\text{C}; \text{I}_{D} = 120 \text{ A}; \\ V_{sup} \leq 100 \text{ V}; \text{R}_{GS} = 50 \Omega; \text{ unclamped}; \\ \hline \text{Fig. 3}$		-	-	542	mJ

5. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	mb	D
2	D	drain[1]		
3	S	source		G-UTA
mb	D	mounting base; connected to drain	$\begin{bmatrix} 1 & 2 & \\ 1 & 3 \end{bmatrix}$	mbb076 S
			D2PAK (SOT404)	

[1] It is not possible to make connection to pin 2

6. Ordering information

Table 3 Ordering information

Table 3. Ordering in	rormation						
Type number	Package	je					
	Name	Description	Version				
PSMN4R8-100BSE	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404				

7. Marking

Table 4. Marking codes	
Type number	Marking code
PSMN4R8-100BSE	PSMN4R8-100BSE

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

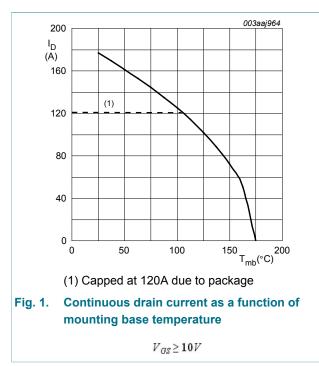
Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	100	V
V _{DGR}	drain-gate voltage	T _j ≥ 25 °C; T _j ≤ 175 °C; R _G	_S = 20 kΩ	-	100	V
V _{GS}	gate-source voltage			-20	20	V
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Symbol	Parameter	Conditions		Min	Мах	Unit
I _D	drain current	V _{GS} = 10 V; T _j = 25 °C; <u>Fig. 1</u>	[1]	-	120	А
		V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 1</u>	[1]	-	120	А
I _{DM}	peak drain current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^\circ C$; Fig. 4		-	707	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 2</u>		-	405	W
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
T _{sld(M)}	peak soldering temperature			-	260	°C
Source-drai	in diode		1			
I _S	source current	T _{mb} = 25 °C	[1]	-	120	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^\circ C$		-	707	А
Avalanche I	Ruggedness		1			
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 120 A; V_{sup} ≤ 100 V; R_{GS} = 50 Ω; unclamped; Fig. 3		-	542	mJ

[1] Continuous current limited by package.



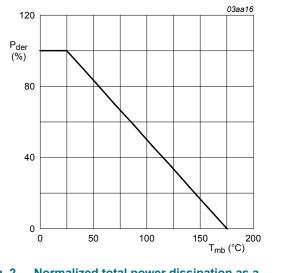
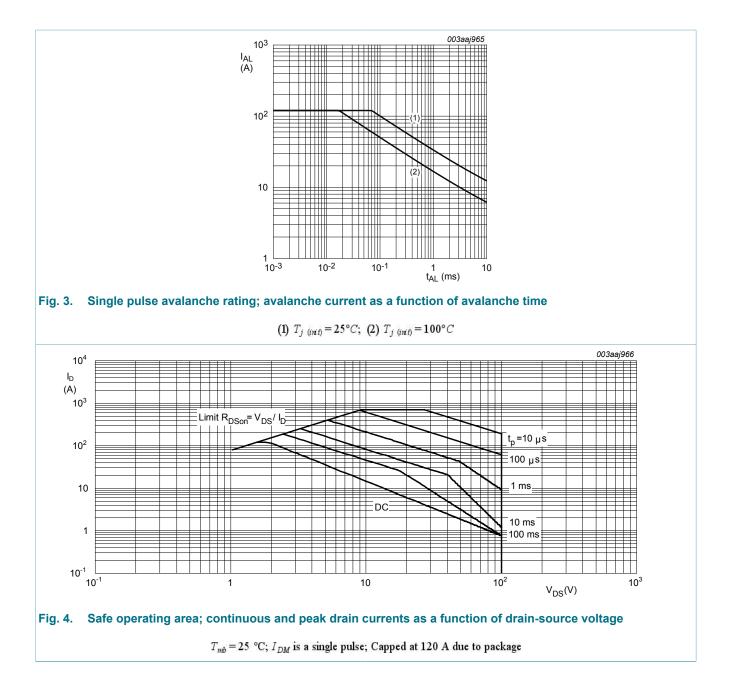


Fig. 2. Normalized total power dissipation as a function of mounting base temperature

$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

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N-channel 100 V 4.8 mΩ standard level MOSFET in D2PAK

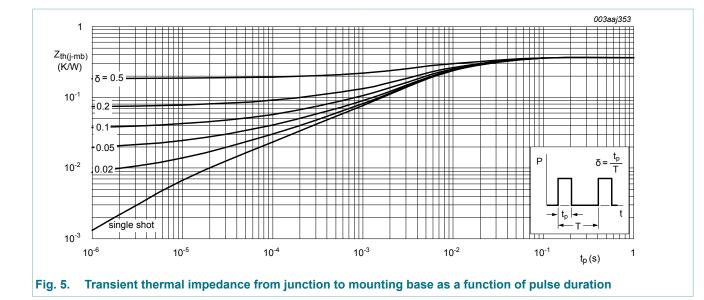


9. Thermal characteristics

Table 6. The	rmal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	Fig. <u>5</u>	-	0.3	0.37	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	Minimum footprint; mounted on a printed circuit board	-	50	-	K/W

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N-channel 100 V 4.8 m Ω standard level MOSFET in D2PAK



10. Characteristics

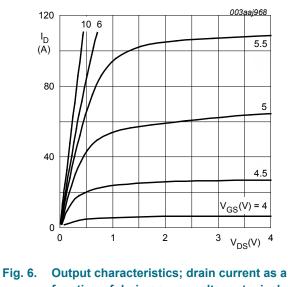
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics	· · · · ·				
V _{(BR)DSS}	drain-source	I _D = 250 μA; V _{GS} = 0 V; T _j = 25 °C	100	-	-	V
	breakdown voltage	I _D = 250 μA; V _{GS} = 0 V; T _j = -55 °C	90	-	-	V
V _{GS(th)}	gate-source threshold voltage	I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 25 °C; Fig. 10; Fig. 11	2	3	4	V
V _{GSth}	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 175 °C; Fig. 11	1	-	-	V
		I_D = 1 mA; V_{DS} = V_{GS} ; T_j = -55 °C; Fig. 11	-	-	4.6	V
I _{DSS}	drain leakage current	V_{DS} = 100 V; V_{GS} = 0 V; T_j = 25 °C	-	0.16	10	μA
		V _{DS} = 100 V; V _{GS} = 0 V; T _j = 175 °C	-	-	500	μA
I _{GSS}	gate leakage current	V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
		V_{GS} = 20 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; Fig. 12	-	4.1	4.8	mΩ
		V _{GS} = 10 V; I _D = 25 A; T _j = 100 °C; Fig. 13; Fig. 12	-	-	8.7	mΩ
		V _{GS} = 10 V; I _D = 25 A; T _j = 175 °C; Fig. 12; Fig. 13	-	-	13	mΩ
R _G	gate resistance	f = 1 MHz	0.43	0.85	1.7	Ω

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N-channel 100 V 4.8 m Ω standard level MOSFET in D2PAK

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Dynamic cl	haracteristics		I			
Q _{G(tot)}	total gate charge	I _D = 25 A; V _{DS} = 50 V; V _{GS} = 10 V; Fig. 14; Fig. 15	-	196	278	nC
		$I_D = 0 A; V_{DS} = 0 V; V_{GS} = 10 V$	-	166.9	234	nC
Q _{GS}	gate-source charge	I_D = 25 A; V_{DS} = 50 V; V_{GS} = 10 V;	-	40	56	nC
Q _{GD}	gate-drain charge	<u>Fig. 14; Fig. 15</u>	-	59	83	nC
V _{GS(pl)}	gate-source plateau voltage	I _D = 25 A; V _{DS} = 50 V; <u>Fig. 14</u> ; <u>Fig. 15</u>	-	4.3	-	V
C _{iss}	input capacitance	V _{DS} = 50 V; V _{GS} = 0 V; f = 1 MHz; T _j = 25 °C; <u>Fig. 16</u>	-	10665	14400	pF
C _{oss}	output capacitance		-	674	910	pF
C _{rss}	reverse transfer capacitance		-	459	643	pF
t _{d(on)}	turn-on delay time	V_{DS} = 50 V; R _L = 2 Ω; V _{GS} = 10 V;	-	41	61.5	ns
t _r	rise time	$R_{G(ext)} = 4.7 \Omega$	-	65	97.5	ns
t _{d(off)}	turn-off delay time		-	127	190.5	ns
t _f	fall time		-	69	103.5	ns
Source-dra	iin diode		1		1	
V _{SD}	source-drain voltage	$I_{\rm S}$ = 25 A; $V_{\rm GS}$ = 0 V; $T_{\rm j}$ = 25 °C; <u>Fig. 17</u>	-	0.79	1.2	V
t _{rr}	reverse recovery time	I_{S} = 25 A; dI _S /dt = -100 A/µs; V _{GS} = 0 V; V _{DS} = 50 V	-	72	94	ns
Q _r	recovered charge		-	227	296	nC







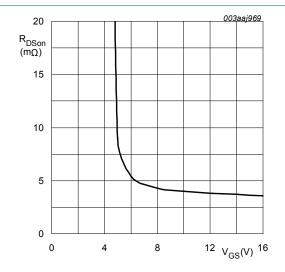
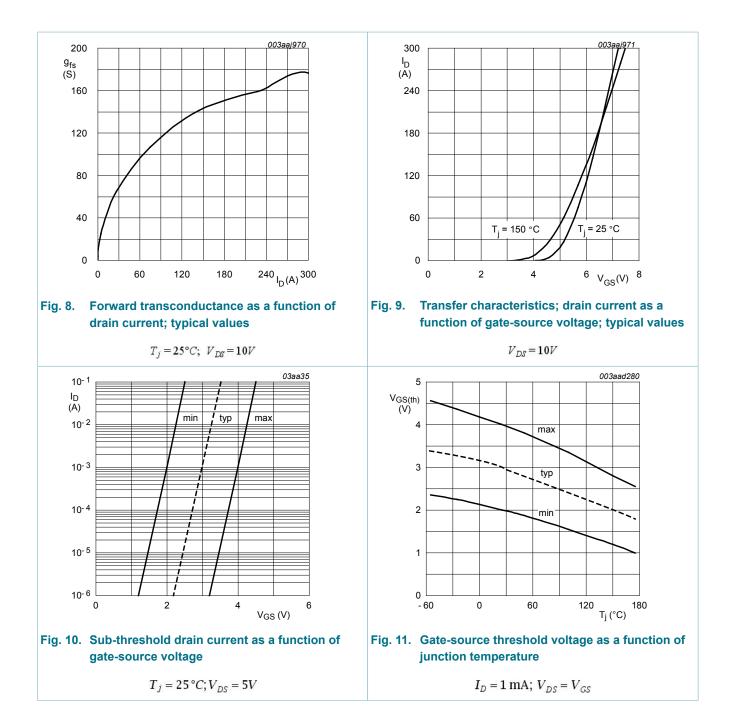


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

 $T_j = 25^{\circ}C; \ I_D = 25A$

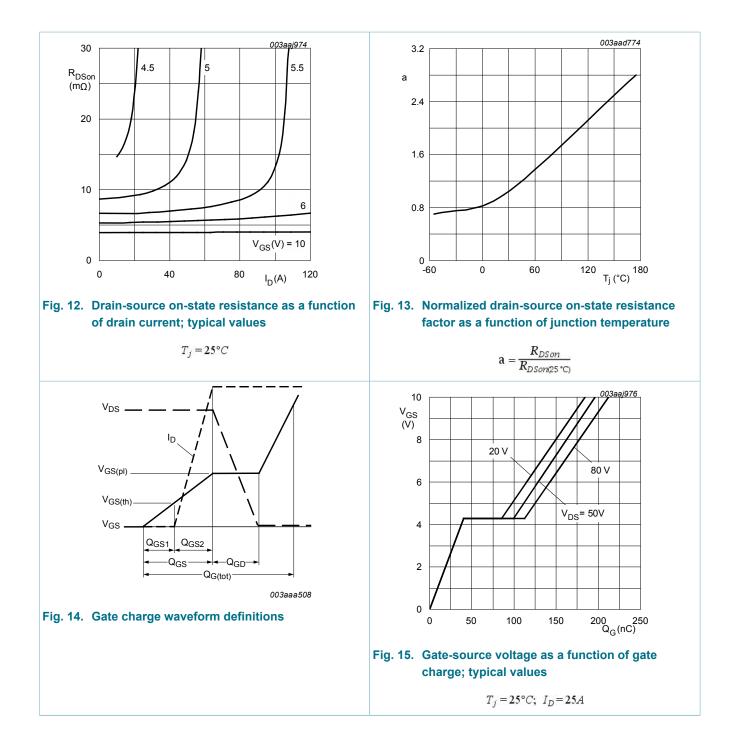
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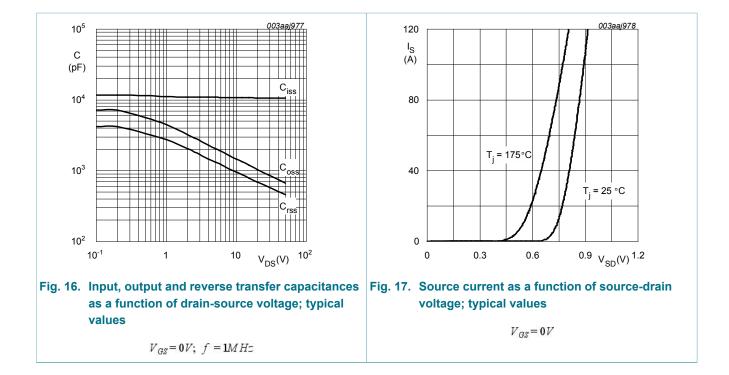
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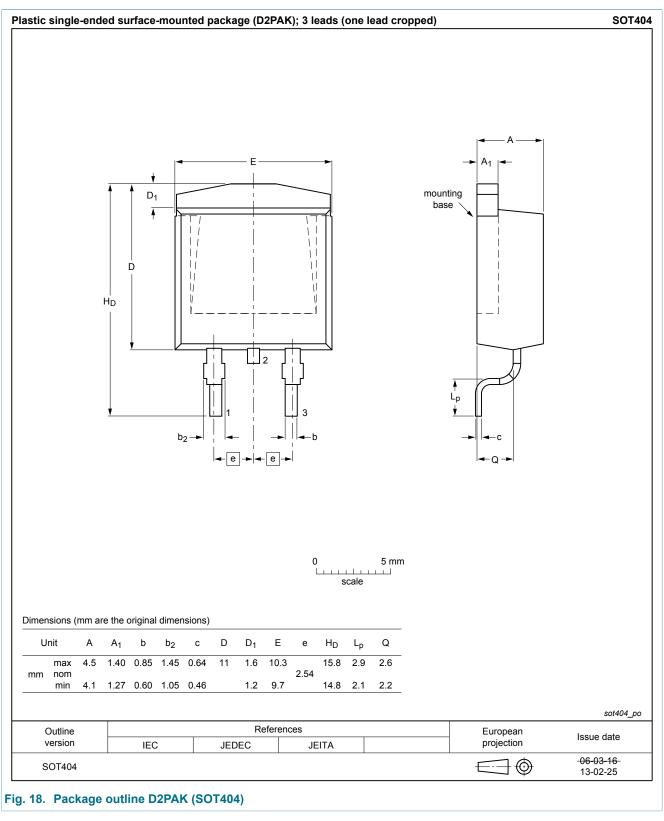
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11. Package outline



N-channel 100 V 4.8 m Ω standard level MOSFET in D2PAK

12. Legal information

12.1 Data sheet status

Document status [1][2]	Product status [<u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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